

X7R Dielectric

General Specifications



X7R formulations are called “temperature stable” ceramics and fall into EIA Class II materials. X7R is the most popular of these intermediate dielectric constant materials. Its temperature variation of capacitance is within $\pm 15\%$ from -55°C to $+125^{\circ}\text{C}$. This capacitance change is non-linear.

Capacitance for X7R varies under the influence of electrical operating conditions such as voltage and frequency.

X7R dielectric chip usage covers the broad spectrum of industrial applications where known changes in capacitance due to applied voltages are acceptable.



PART NUMBER (SEE PAGE 4 FOR COMPLETE PART NUMBER EXPLANATION)

0805

Size
(L" x W")

5

Voltage
4V = 4
6.3V = 6
10V = Z
16V = Y
25V = 3
50V = 5
100V = 1
200V = 2
500V = 7

C

Dielectric
X7R = C

103

Capacitance Code (In pF)
2 Sig. Digits + Number of Zeros

M

Capacitance Tolerance
J = $\pm 5\%*$
K = $\pm 10\%$
M = $\pm 20\%$

* $\leq 1\mu\text{F}$ only,
contact factory for additional values

A

Failure Rate
A = Not Applicable

T

Terminations
T = Plated Ni and Sn
Z = FLEXITERM^{®**}

*Optional termination

**See FLEXITERM[®] X7R section

2

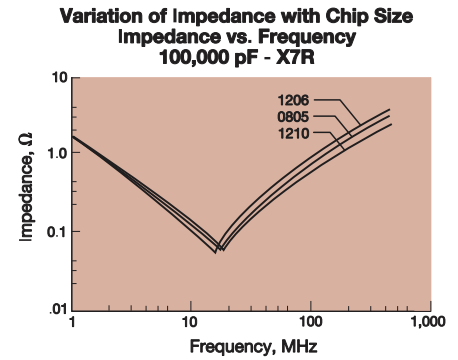
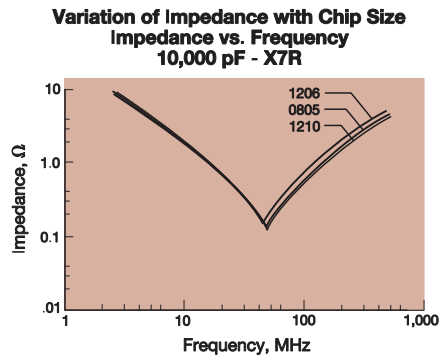
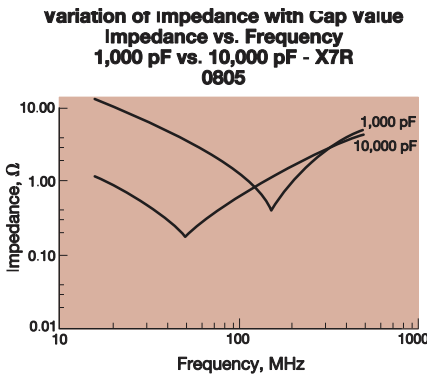
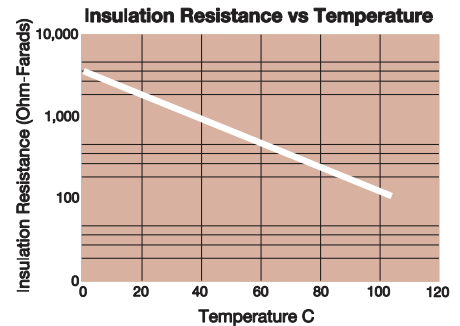
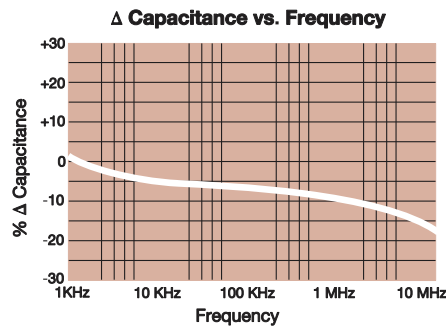
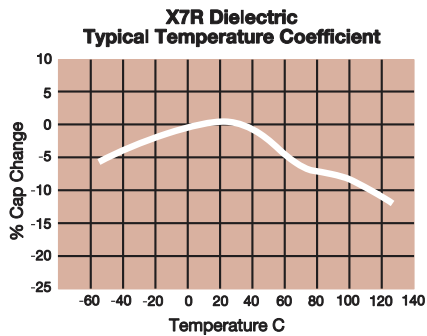
Packaging
2 = 7" Reel
4 = 13" Reel

Contact Factory For Multiples

A

Special Code
A = Std. Product

NOTE: Contact factory for availability of Termination and Tolerance Options for Specific Part Numbers. Contact factory for non-specified capacitance values.



X7R Dielectric

Specifications and Test Methods



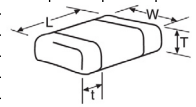
Parameter/Test		X7R Specification Limits	Measuring Conditions	
Operating Temperature Range		-55°C to +125°C	Temperature Cycle Chamber	
Capacitance		Within specified tolerance		
Dissipation Factor		$\leq 10\%$ for $\geq 50V$ DC rating $\leq 12.5\%$ for 25V DC rating $\leq 12.5\%$ for $\leq 10V$ DC rating Contact Factory for DF by PN	Freq.: 1.0 kHz $\pm 10\%$ Voltage: 1.0Vrms $\pm .2V$ For Cap > 10 μ F, 0.5Vrm @ 120Hz	
Insulation Resistance		10,000M Ω or 500M Ω · μ F, whichever is less	Charge device with rated voltage for 120 \pm 5 secs @ room temp/humidity	
Dielectric Strength		No breakdown or visual defects	Charge device with 250% of rated voltage for 1-5 seconds, w/ charge and discharge current limited to 50 mA (max) Note: Charge device with 150% of rated voltage for 500V devices.	
Resistance to Flexure Stresses	Appearance	No defects	Deflection: 2mm Test Time: 30 seconds	
	Capacitance Variation	$\leq \pm 12\%$		
	Dissipation Factor	Meets Initial Values (As Above)		
	Insulation Resistance	\geq Initial Value x 0.3		
Solderability		$\geq 95\%$ of each terminal should be covered with fresh solder	Dip device in eutectic solder at 230 \pm 5°C for 5.0 \pm 0.5 seconds	
Resistance to Solder Heat	Appearance	No defects, <25% leaching of either end terminal	Dip device in eutectic solder at 260°C for 60 seconds. Store at room temperature for 24 \pm 2 hours before measuring electrical properties.	
	Capacitance Variation	$\leq \pm 7.5\%$		
	Dissipation Factor	Meets Initial Values (As Above)		
	Insulation Resistance	Meets Initial Values (As Above)		
	Dielectric Strength	Meets Initial Values (As Above)		
Thermal Shock	Appearance	No visual defects	Step 1: -55°C $\pm 2^\circ$	30 \pm 3 minutes
	Capacitance Variation	$\leq \pm 7.5\%$	Step 2: Room Temp	≤ 3 minutes
	Dissipation Factor	Meets Initial Values (As Above)	Step 3: +125°C $\pm 2^\circ$	30 \pm 3 minutes
	Insulation Resistance	Meets Initial Values (As Above)	Step 4: Room Temp	≤ 3 minutes
	Dielectric Strength	Meets Initial Values (As Above)	Repeat for 5 cycles and measure after 24 \pm 2 hours at room temperature	
Load Life	Appearance	No visual defects	Pre-treatment: After mounting, perform heat treatment 150+0/-10C for 2 hour, then stabilise for 24+/-2 hour at room temp, then measure. Charge device with \geq rated voltage in test chamber set at 125°C $\pm 2^\circ$ C for 1000 hours (+48, -0). Pre-treatment: After remove from test chamber, perform heat treatment 150+0/-10C for 2 hour, then stabilise for 24+/-2 hour at room temp, then measure. Contact KYOCERA AVX for datasheet of specific parts.	
	Capacitance Variation	$\leq \pm 12.5\%$		
	Dissipation Factor	\leq Initial Value x 2.0 (See Above)		
	Insulation Resistance	\geq Initial Value x 0.3 (See Above)		
	Dielectric Strength	Meets Initial Values (As Above)		
Load Humidity	Appearance	No visual defects	Take the initial value after heat treatment. After applying rated voltage for 500+12/ -0 hours in the condition of 40°C $\pm 2^\circ$ C and 90 to 95%RH, and place in normal temperature and humid- ity, then measure the sample after heat treatment. The charge and discharge current of the capacitor must not exceed 50mA for IR measurement.	
	Capacitance Variation	$\leq \pm 12.5\%$		
	Dissipation Factor / Tan δ	Within specification		
	Insulation Resistance	Over 1000M Ω or 50M Ω · μ F, whichever is less. *Exceptions Listed Below		

X7R Dielectric Capacitance Range



PREFERRED SIZES ARE SHADED

SIZE	1210							1812					1825			2220				2225					
	Reflow Only Paper/Embossed							Reflow Only All Embossed					Reflow Only All Embossed			Reflow Only All Embossed				Reflow Only All Embossed					
(L) Length	mm (in.)	3.30 ± 0.4 (0.130 ± 0.016)							4.50 ± 0.40 (0.177 ± 0.016)					4.50 ± 0.40 (0.177 ± 0.016)			5.70 ± 0.50 (0.224 ± 0.020)				5.70 ± 0.40 (0.224 ± 0.016)				
(W) Width	mm (in.)	2.50 ± 0.30 (0.098 ± 0.012)							3.20 ± 0.40 (0.126 ± 0.016)					6.40 ± 0.40 (0.252 ± 0.016)			5.00 ± 0.40 (0.197 ± 0.016)				6.30 ± 0.40 (0.248 ± 0.016)				
(t) Terminal	mm (in.)	0.50 ± 0.25 (0.020 ± 0.010)							0.61 ± 0.36 (0.024 ± 0.014)					0.61 ± 0.36 (0.024 ± 0.014)			0.64 ± 0.39 (0.025 ± 0.015)				0.64 ± 0.39 (0.025 ± 0.015)				
WVDC		10	16	25	50	100	200	500	16	25	50	100	200	500	50	100	200	25	50	100	200	500	50	100	200
Cap (pF)		100	101																						
		150	151																						
		220	221																						
		330	331																						
		470	471																						
		680	681																						
		1000	102																						
		1500	152																						
		2200	222																						
		3300	332																						
		4700	472																						
		6800	682																						
Cap (µF)		0.01	103																						
		0.015	153																						
		0.022	223																						
		0.033	333																						
		0.047	473																						
		0.068	683																						
		0.1	104																						
		0.15	154																						
		0.22	224																						
		0.33	334																						
		0.47	474																						
		0.68	684																						
		1.0	105																						
		1.5	155																						
		2.2	225																						
		3.3	335																						
		4.7	475																						
		10	106																						
		22	226																						
		47	476																						
		100	107																						
WVDC		10	16	25	50	100	200	500	16	25	50	100	200	500	50	100	200	25	50	100	200	500	50	100	200
SIZE		1210							1812					1825			2220				2225				



Letter	A	B	C	E	G	J	K	M	N	P	Q	X	Y	Z	7	
Max. Thickness	0.33 (0.013)	0.22 (0.009)	0.56 (0.022)	0.71 (0.028)	0.90 (0.035)	0.94 (0.037)	1.02 (0.040)	1.27 (0.050)	1.40 (0.055)	1.52 (0.060)	1.78 (0.070)	2.29 (0.090)	2.54 (0.100)	2.79 (0.110)	3.30 (0.130)	
	PAPER						EMBOSS									

NOTE: Contact factory for non-specified capacitance values